

## IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Application Serial No	09/212.726
Filing Date	
Inventor	Klaus Florian Schuegraf
Assignee	Micron Technology, Inc.
Group Art Unit	2813
Examiner	Erik J. Kielin
Attorney's Docket No	MI22-1098
Title: Semiconductor Processing Methods of Chemical	Vapor Depositing SiO <sub>2</sub> on
a Substrate	

## SUPPLEMENTAL INFORMATION DISCLOSURE STATEMENT

References -See Attached Form PTO-1449

The Examiner's attention is directed to the reference which is listed on the attached Form PTO-1449, a copy of the abstract of which is attached. No admission is made regarding whether the submitted reference is prior art.

Citation of the referenced art is respectfully requested.

Respectfully submitted,

Dated: September 14

lennifer J. Taylor, Ph.D

Reg. No. 48,711

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Sheet 1 of 1 ATTY. DOCKET SERIAL NO. Form PTO-1449 U.S. DEPARTMENT OF COMMERCE 09/212,726 PATENT AND TRADEMARK OFFICE NO. MI22-1098 LIST OF ART CITED BY APPLICANT **APPLICANT** (Use several sheets if necessary) Klauf Florian Schuegraf FILING DATE **GROUP** December 15, 1998 2813 **U.S. PATENT DOCUMENTS** \*Examine Document Date Name Class Sub-Filing Date Number class lf Initial Appropriate 4,767,429 08-1988 AA Fleming et al. AB 5,593,741 01-1997 Ikeda AC ΑD AΕ FOREIGN PATENT DOCUMENTS Document -Date Country Class Sub-Translation Number class Yes No AL JP03125930 04-1992 Japan AM JP08130245 05-1996 Japan ΑN ΑO AΡ OTHER REFERENCES (including Author, Title, Date, Pertinent Pages, Etc.) AQ AR

**EXAMINER** 

AS

DATE CONSIDERED

\*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.